

Notice of References Cited	Application/Control No. 10/751,749		Applicant(s)/Patent Under Reexamination HEATH, KEVIN R.	
	Examiner Hieu Phan		Art Unit 3738	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-5,824,077	10-1998	Mayer, David W.	623/11.11
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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